Notice of References Cited Application/Control No. 10/606,500 Applicant(s)/Patent Under Reexamination HATAOKA ET AL. Examiner Thuy V. Tran Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-US 2002/047611 A1	04-2002	Kaneko et al.	315/246
	В	US-6,734,628	05-2004	Seki et al.	313/623
	С	US-6,693,379	02-2004	Nishida, Kazuhisa	315/56
	D	US-6,232,719	05-2001	Kaneko et al.	313/625
	E	US-4,647,814	03-1987	Dobrusskin et al.	313/641
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.